

# Test-beam campaign for the characterization of innovative photodetectors for Ring-Imaging Cherenkov applications

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May 22, 2025



# 4DPHOTON project

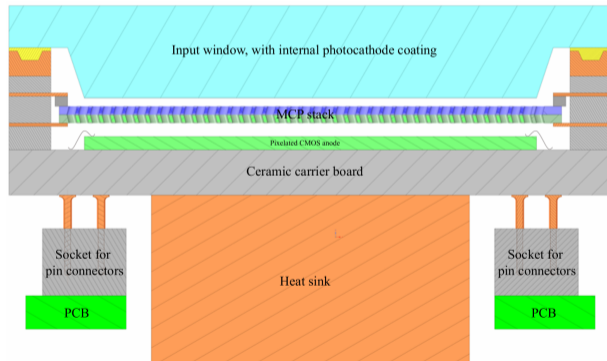
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# Novel hybrid photon detector

**Goal:** new photodetector based on MCP with simultaneous timing ( $< 100$  ps) and spatial resolution ( $\sim 5\text{-}10\ \mu\text{m}$ ) with low dark count rate at room temperature

“Hybrid” assembly based on tube kept under high vacuum

- ▷ Photocathode deposited in the inner part of the input window
- ▷ MCP stack (Chevron or Z-stack configuration)
- ▷ Pixelated CMOS anode: Timepix4 ASIC
- ▷ Ceramic carrier board
- ▷ PCBs to connect the detector to a FPGA-based DAQ system



[M. Fiorini et al, JINST 13 (2018) C12005]

# Operating principle

Photon conversion producing a photo-electron



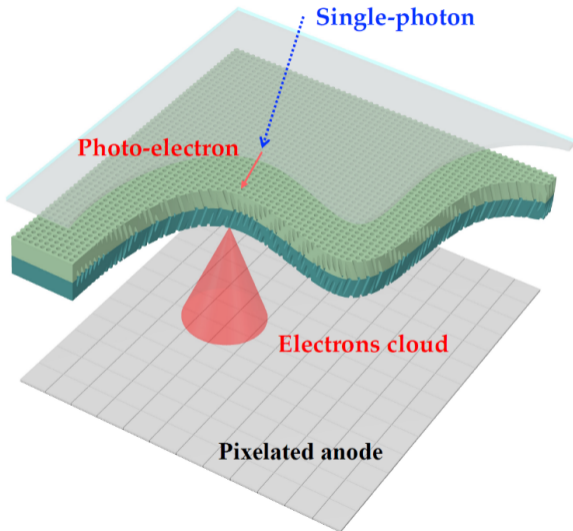
The photo-electron is transported by a drift electric field onto a microchannel plate (MCP)



The electrons cloud produced by the MCP is carried onto the input (bump-bonding) pads of the bare Timepix4 ASIC



The Timepix4 ASIC will amplify, discriminate and digitize the MCP signal inside the vacuum tube

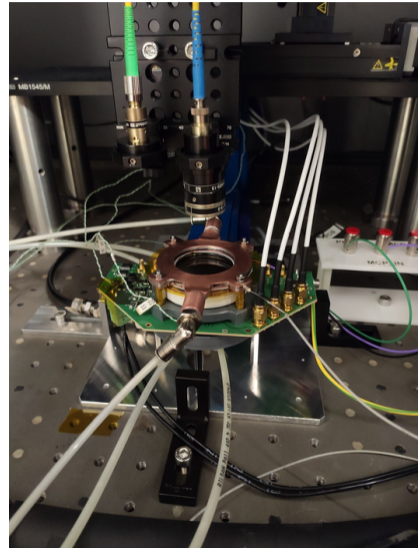


# Prototype characterization

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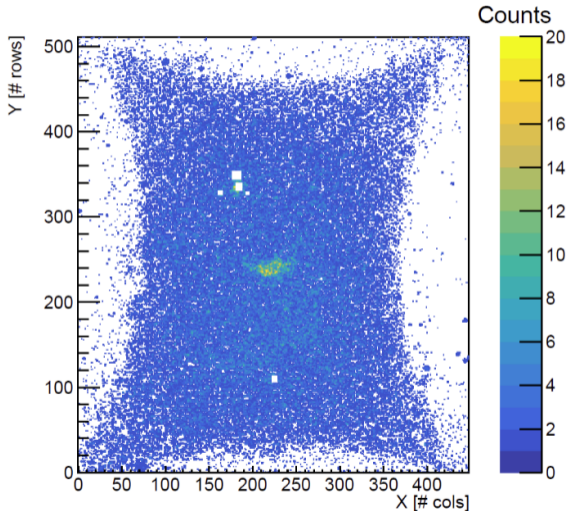
# Characterization setup

- ▶ Tube prototypes received from Hamamatsu HPK mounted on custom carrier board within a dark box
- ▶ Liquid cooling system to maintain stable temperature inside the tube
- ▶ Timepix4 controlled through either SPIDR4 or custom control board developed by INFN, located outside the box
- ▶ Collimated laser 405 nm



# DCR measurement - non uniform structure

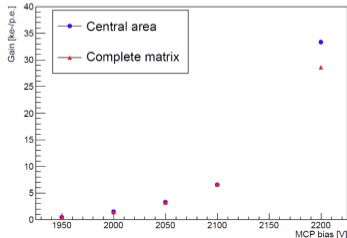
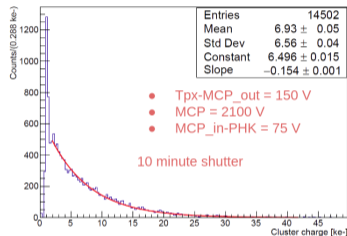
- ▷ Gain and dark count rate measurements performed
- ▷ Several HV parameters set between the different elements
- ▷ Non-uniform dark count structure
  - ▷ Curved regions on the Timepix4 sides receive less counts
  - ▷ Laser measurements ruled out the possibility of field distortions strong enough to explain the observed distribution
  - ▷ Distribution due to gain differences across the matrix. The reason of these gain differences is under investigation



# Gain measurements

Gain estimated with cluster charge distribution at different MCP voltages performing DCR measurements

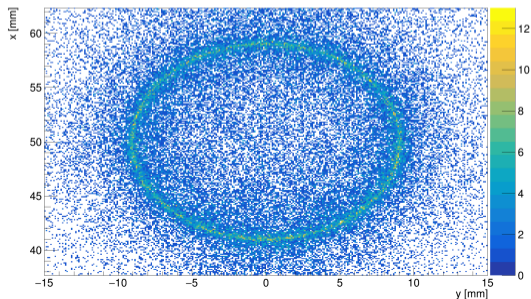
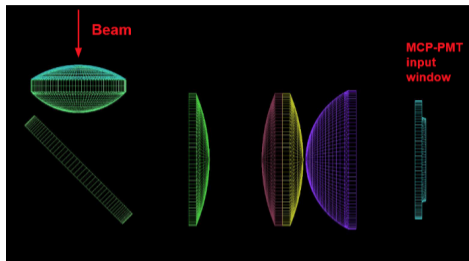
- ▶ At low gain, exponential distribution as expected
- ▶ Gain estimate also considering only the central region
  - ▶ Compatible at low MCP bias
  - ▶ At higher MCP bias the low gain area along the edges is populated and affects the total gain estimation
- ▶ Working point defined at 2100 V for the MCP



# Testbeam campaign

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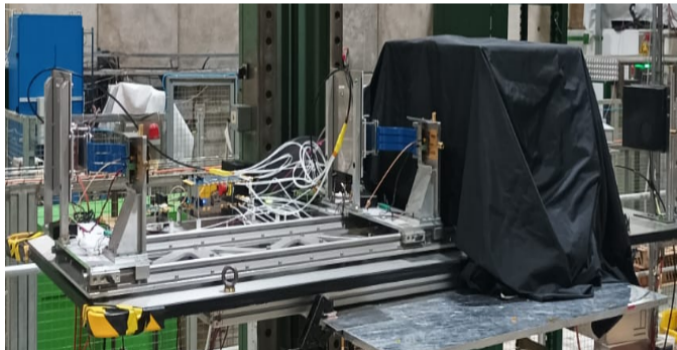
- ▷ Various test to optimize the configuration and study the impact of each component
  - ▷ Resolution optimisation
  - ▷ Material impact on momentum distribution
  - ▷ Background studies
- ▷ Lenses system configuration
  - ▷ Used Zemax to optimise the system
  - ▷ Incorrect description of Geant4 of the obj extracted from Zemax
  - ▷ Only commercial plano-convex lenses have been used



# Testbeam setup 1/2

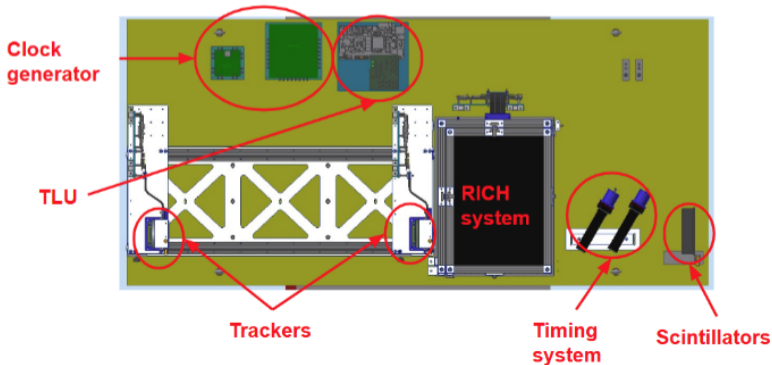
Testbeam in SPS NA beamlines (21-31 October)

- ▷ Custom Trigger Logic Unit (TLU) to use the spill extraction signal as shutter signal
- ▷ Common external reference clock
- ▷ Beam: 80 % protons, 20 % pions, 1 % muons at  $E > 100$  GeV



## Testbeam setup 2/2

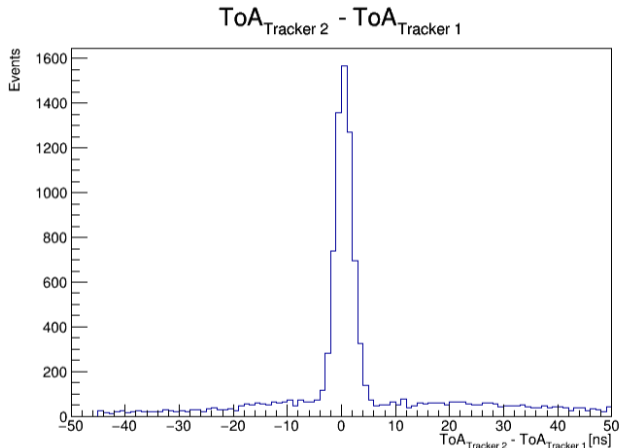
- ▷ **Trackers:** 2 Timepix4 assemblies bonded to 300  $\mu\text{m}$  thick p-on-n planar Si detector
- ▷ **Lens system:** Cherenkov radiator and optics setup to produce and focus Cherenkov ring
- ▷ **4DPHOTON:** DUT, placed off-beam
- ▷ **Timing-systems:** 2 Cherenkov detectors to provide timing reference
- ▷ **Scintillators:** to monitor the beam intensity



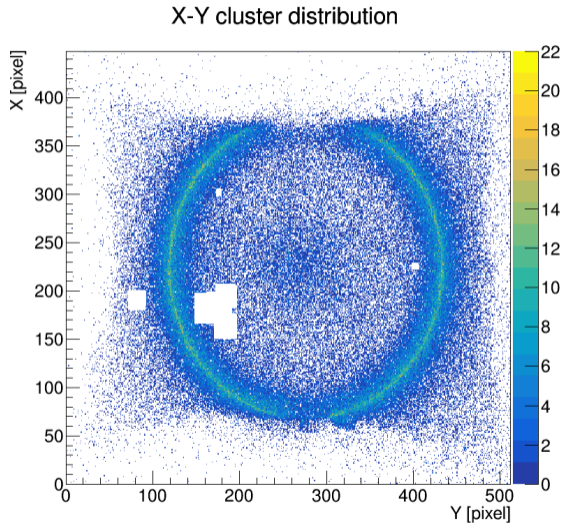
# Testbeam analysis - Event selection 1/2

Initial event selection:

- ▶ Only one hit in each tracker,  
 $\Delta t_{max} = 10$  ns
- ▶ At least 1 hit in the 4DPHOTON detector within 5 ns from the second tracker hit
- ▶ Every hit in the 4DPHOTON detector within 50 ns from the second tracker hit
- ▶ At least 10 hit in the 4DPHOTON detector (expected 15-20)

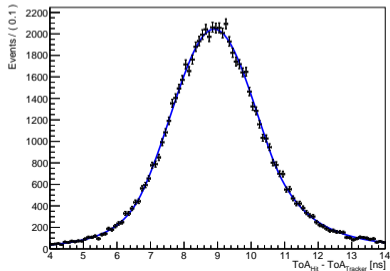
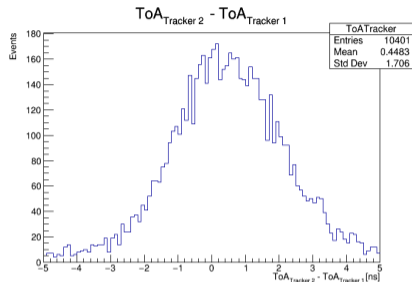


- ▷ Cherenkov ring observed
  - ▷ Ring appears slightly distorted → small misalignment in the optical system
  - ▷ Observed ring position and dimension as expected from the simulation
- ▷ Same non-uniform dark count structure



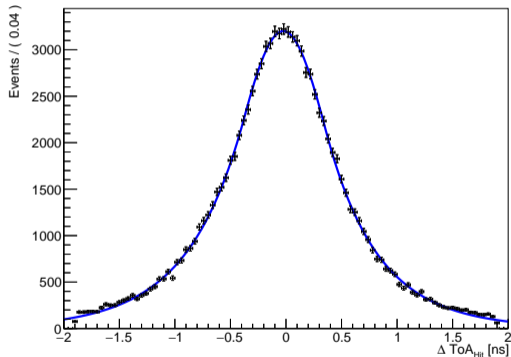
# Testbeam analysis - Time resolution 1/2

- ▶ Reference timing system noisy, low-resolution, and unreliable
  - ▶ Using tracker as reference
  - ▶ Low resolution, low voltage applied (100V)
  - ▶ High contribution in the detector resolution
- ▶ For each photon in the ring candidates calculate  $ToA_{Hit} - ToA_{Tracker}$
- ▶ Fit the distribution using a Crystal Ball function to account for background from noise and non-Cherenkov events.
- ▶ Resulting in  $\sigma_{4DPHOTO} \simeq 1.3$  ns



## Testbeam analysis - Time resolution 2/2

- ▶ To eliminate external contributions → ring hits used as reference
  - ▶ Randomly divide ring hits into two subsystems
  - ▶ Subtract hits from one subsystem to the other
- ▶ Resulting in  $\sigma_{4DPHOTO} \simeq 400$  ps
- ▶ This result is closer to the expected values of  $\sigma_{\text{expected}} \simeq 100$  ps (as measured in lab)



# Conclusion

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## Next steps and conclusions

- ▷ Another testbeam in schedule for the end of the year
  - ▷ Change the time reference system → simulate new setup with different materials and dimensions
  - ▷ Improve tracker performance
- ▷ To improve the current measurements:
  - ▷ New calibration measurements for the trackers and 4DPHOTON
  - ▷ Test other strategy using different time references
  - ▷ Test and deeper characterisation of the detector in laboratory
- ▷ Expected resolution close the measured one → to be improved during the next testbeam!